

EMC Test Report

Report No.: AGC05443230709EE01

PRODUCT DESIGNATION: 10000mAh Power bank

BRAND NAME : N/A

MODEL NAME : M06863

APPLICANT: MID OCEAN BRANDS B.V

DATE OF ISSUE : Aug. 02, 2023

EN 55032:2015/A11:2020

STANDARD(S) : EN IEC 61000-3-2:2019/A1:2021

EN 61000-3-3:2013/A2:2021

EN 55035:2017/A11:2020

REPORT VERSION: V1.0





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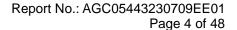
REPORT REVISE RECORD

| Report Version | Revise Time | Issued Date | Valid Version | Notes | |
|----------------|-------------|---------------|---------------|-----------------|--|
| V1.0 | / | Aug. 02, 2023 | Valid | Initial release | |



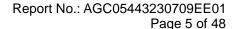
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1. VERIFICATION OF CONFORMITY

| Applicant | MID OCEAN BRANDS B.V |
|------------------------------|---|
| Address | 7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong |
| Manufacturer | MID OCEAN BRANDS B.V |
| Address | 7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong |
| Factory | MID OCEAN BRANDS B.V |
| Address | 7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong |
| Product Designation | 10000mAh Power bank |
| Brand Name | N/A |
| Test Model | MO6863 |
| Date of receipt of test item | Jul. 13, 2023 |
| Date of test | Jul. 13, 2023 to Aug. 02, 2023 |
| Deviation | No deviation from the test method. |
| Condition of Test Sample | Normal |
| Test Result | Pass |

The above equipment was tested by Attestation of Global Compliance (Shenzhen) Co., Ltd. for compliance with the requirements set forth in the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

| Prepared By | Cocili | |
|-------------|-----------------------------------|---------------|
| | Cici Li (Project Engineer) | Aug. 02, 2023 |
| Reviewed By | Calin Lin | |
| | Calvin Liu (Reviewer) | Aug. 02, 2023 |
| Approved By | Max Zhang | |
| | Max Zhang (Authorized Officer) | Aug. 02, 2023 |



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2. SYSTEM DESCRIPTION

| | TEST MODE DESCRIPTION | | | | | |
|-----|--|-------|--|--|--|--|
| NO. | TEST MODE DESCRIPTION | WORST | | | | |
| 1 | Full load output mode with charging by Micro USB | V | | | | |
| 2 | Full load output mode with charging by USB | | | | | |
| 3 | USB-A output mode with charging by Micro USB | | | | | |
| 4 | USB-A output mode with charging by USB | | | | | |

Note:

- 1. V means EMI worst mode.
- All modes have been tested and only the worst mode test data recorded in the test report.

3. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by ISO.

- Uncertainty of Conducted Emission, Uc = ±2.9 dB
- Uncertainty of Radiated Emission (Below 1G), Uc = ±3.9 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.9dB



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4. PRODUCT INFORMATION

| Housing Type | Plastic and metal |
|-------------------|---|
| Hardware Version | N/A |
| Software Version | N/A |
| | Micro USB Input: DC 5V/2A Cable with USB Input::DC 5V/2A |
| EUT Output Rating | USB-A Output: DC 5V/2A Cable with Type-C Output: DC5V/2A Cable with Micro Output: DC5V/2A Cable with 2 in 1 Output: DC5V/2A Capacity: 10000mAh/37Wh Total output: 5V 2A |

I/O Port Information (⊠Applicable □Not Applicable)

| I/O Port of EUT | | | | | | |
|----------------------|---|-------------------|-------------|--|--|--|
| I/O Port Type Number | | Cable Description | Tested With | | | |
| USB Input | 1 | 0.45m Unshielded | 1 | | | |
| Micro-B Input | 1 | | 1 | | | |
| Type-C Output | 1 | | 1 | | | |
| Micro-B Output | 1 | | 1 | | | |
| USB-A Output | 1 | | 1 | | | |
| 2 in 1 Output | 1 | | 1 | | | |



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5. SUPPORT EQUIPMENT

| Device Type | Manufacturer | Model Name | Serial No. | Data Cable | Power Cable |
|--------------|--------------|--------------------|------------|------------|--------------------------------------|
| iPod | APPLE | MGG82ZP/A | | | 0.12m,unshielded |
| Xiaomi phone | Xiaomi | Mi 10 | 1 | - | 0.09m,unshielded |
| OPPO phone | ОРРО | A9 | OPPO | OPPO | 0.09m,unshielded |
| Adapter | jinbaotong | K-T10E050200 0E | | | AC100-240V,50-60Hz,0.35A,DC5 V/2A |

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.



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6. TEST FACILITY

| Site | Attestation of Global Compliance (Shenzhen) Co., Ltd |
|----------|---|
| Location | 1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao 'an District, Shenzhen, Guangdong, China |

7. TEST EQUIPMENT LIST

TEST EQUIPMENT OF CONDUCTED EMISSION TEST

| Equipment | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|--------------------------|--------------|---------|------------|---------------|---------------|
| Test Receiver | R&S | ESPI | 101206 | Aug. 04, 2022 | Aug. 03, 2023 |
| Artificial power network | R&S | ESH2-Z5 | 100086 | Jun. 03, 2023 | Jun. 02, 2024 |
| Test software | R&S | ES-K1 | Ver.V1.7.1 | N/A | N/A |

TEST EQUIPMENT OF RADIATED EMISSION TEST

| Equipment | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|------------------------------------|--------------|------------------|------------|---------------|---------------|
| Test Receiver | R&S | ESCI | 10096 | Feb. 18, 2023 | Feb. 17, 2024 |
| Antenna | SCHWARZBECK | VULB9168 | 494 | Jan. 05, 2023 | Jan. 04, 2025 |
| Double-Ridged Waveguide Horn | ETS | 3117 | 00034609 | Mar. 23, 2023 | Mar. 22, 2024 |
| Preamplifier Assembly | ETS | 3117PA | 00225134 | Sep. 02, 2022 | Sep. 01, 2024 |
| EXA Signal Analyzer | Aglient | N9010A | MY53470504 | Aug. 04, 2022 | Aug. 03, 2023 |
| Test software | Tonscend | JS32-RE(Ver.2.5) | N/A | N/A | N/A |

TEST EQUIPMENT OF POWER HARMONICS / VOLTAGE FLUCTUATION / FLICKER TEST

| Equipment | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|--------------------------------|--------------|-----------|-------|---------------|---------------|
| Signal Conditioning Unit | Schaffner | CCN1000-1 | 72431 | Jun. 08, 2023 | Jun. 07, 2024 |
| AC Source | Schaffner | NSG1007 | 56825 | Jun. 02, 2023 | Jun. 01, 2024 |

TEST EQUIPMENT OF SURGE/EFT/DIPS TEST

| Description | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|------------------------|--------------|-------------|-------|---------------|---------------|
| EFT/Surge Generator | Schaffner | Modula 6150 | 34437 | Jun. 08, 2023 | Jun. 07, 2024 |



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TEST EQUIPMENT OF ESD TEST

| Equipment | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|---------------|--------------|---------|-----|---------------|---------------|
| ESD Simulator | Schaffner | NSG 438 | 782 | Dec. 30, 2022 | Dec. 29, 2023 |

TEST EQUIPMENT OF RS IMMUNITY TEST

| Equipment | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|------------------------------------|--------------|-------------------|-----------------|---------------|---------------|
| Signal Generator | R&S | E4421B | MY43351603 | Feb. 17, 2023 | Feb. 16, 2024 |
| Power Sensor | R&S | URV5-Z4 | 100124 | Mar. 24, 2023 | Mar. 23, 2025 |
| Power Meter | R&S | NRVD | 8323781027 | Mar. 24, 2023 | Mar. 23, 2025 |
| Power Amplifier | KALMUS | 7100LC | 04-02/17-06-001 | N/A | N/A |
| Power Amplifier | Milmega | AS0104-55_55 | 1004793 | N/A | N/A |
| Double-Ridged Waveguide Horn | ETS | 3117 | 00034609 | Mar. 23, 2023 | Mar. 22, 2024 |
| Power Amplifier | rflight | NTWPA-256010 0 | 17063183 | N/A | N/A |
| Antenna | ETS | 3142C | 00060447 | N/A | N/A |

TEST EQUIPMENT OF CS IMMUNITY TEST

| Description | Manufacturer | Model | S/N | Cal. Date | Cal. Due |
|---------------------|--------------|---------|------------|---------------|---------------|
| Power Amplifier | AR | 75A250 | 18464 | N/A | N/A |
| CDN | ZHINAN | ZN3751 | 15004 | Aug. 03, 2022 | Aug. 02, 2024 |
| 6dB attenuator | ZHINAN | E-002 | N/A | Aug. 04, 2022 | Aug. 03, 2024 |
| Power Sensor | R&S | URV5-Z4 | 100124 | Mar. 24, 2023 | Mar. 23, 2025 |
| Power Meter | R&S | NRVD | 8323781027 | Mar. 24, 2023 | Mar. 23, 2025 |
| Signal Generator | R&S | E4421B | MY43351603 | Feb. 17, 2023 | Feb. 16, 2024 |

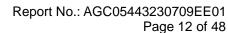


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8. TESTSUMMARY LIST

| Test item | Test Requirement | Test Method | Class/Severity | Result |
|--|------------------|---|--|--------|
| Conducted emission | EN 55032 | EN 55032 | Class B | Pass |
| Radiated emission | EN 55032 | EN 55032 | Class B | Pass |
| Harmonic current emission | EN IEC 61000-3-2 | EN IEC 61000-3-2 | Class A | N/A |
| Voltage fluctuations & flicker | EN 61000-3-3 | EN 61000-3-3 | §5 of EN 61000-3-3 | Pass |
| Electrostatic discharge immunity | EN 55035 | EN 61000-4-2 | ± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge) | Pass |
| Radiated electromagnetic field immunity | EN 55035 | EN 61000-4-3 | 0-4-3 3V/m with 80% AM. 1kHz Modulation. | |
| Electrical fast transient/burst Immunity | EN 55035 | EN 61000-4-4 +/- 1kV for Power Supply Lines | | Pass |
| Surge immunity | EN 55035 | EN 61000-4-5 +/- 1kV (Line to Line) +/- 2kV (Line to Ground) | | Pass |
| Immunity to Conducted Disturbances Induced by RF fields | EN 55035 | EN 61000-4-6 | 3V(0.15MHz-10MHz) 3V-1V(10MHz-30MHz) 1V(30MHz-80MHz) with 80% AM. 1 kHz Modulation | Pass |
| Power frequency magnetic field | EN 55035 | EN 61000-4-8 | 1A/m 50Hz or 60Hz | N/A |
| Voltage dips and short interruptions immunity | EN 55035 | EN 61000-4-11 | 0degrees | Pass |

Note: N/A means not applicable.





9. EN 55032 LINE CONDUCTED EMISSION TEST

9.1. LIMITS OF LINE CONDUCTED EMISSION TEST

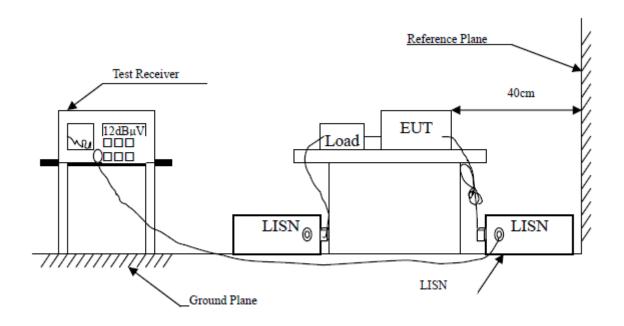
AT AC MAINS POWER PORT

| Francis | Maximum RF Line Voltage | | | | |
|---------------|-------------------------|---------------|--|--|--|
| Frequency | Q.P.(dBuV) | Average(dBuV) | | | |
| 150kHz-500kHz | 66-56 | 56-46 | | | |
| 500kHz-5MHz | 56 | 46 | | | |
| 5MHz-30MHz | 60 | 50 | | | |

Note:

- 1. The lower limit shall apply at the transition frequency.
- 2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50MHz.

9.2. BLOCK DIAGRAM OF TEST SETUP





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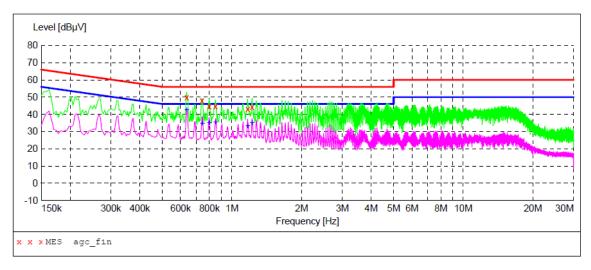
9.3. PROCEDURE OF LINE CONDUCTED EMISSION TEST

- (1)The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN55032 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 10cm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN55032.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN55032.
- (4) The EUT received DC 5V power from adapter which received AC 230V 50Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- (5) All support equipments received power from a second LISN supplying power of AC230V and 110V/50Hz, if any.
- (6) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- (7) Analyzer / Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- (8) During the above scans, the emissions were maximized by cable manipulation.
- (9) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions.
- (10) Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using Q.P and Average detector.



9.4. TEST RESULT OF LINE CONDUCTED EMISSION TEST

LINE CONDUCTED EMISSION TEST-L



MEASUREMENT RESULT: "agc fin"

| 20 | 23/7/31 11: | 13 | | | | | |
|----|------------------|---------------|--------------|---------------|--------------|----------|------|
| | Frequency MHz | Level dBµV | Transd dB | Limit dBµV | Margin dB | Detector | Line |
| | 0.638000 | 49.90 | 6.2 | 56 | 6.1 | QP | L1 |
| | 0.742000 | 48.00 | 6.2 | 56 | 8.0 | QP | L1 |
| | 0.798000 | 44.50 | 6.2 | 56 | 11.5 | QP | L1 |
| | 0.850000 | 44.70 | 6.2 | 56 | 11.3 | QP | L1 |
| | 1.170000 | 43.10 | 6.2 | 56 | 12.9 | QP | L1 |
| | 1.222000 | 44.30 | 6.2 | 56 | 11.7 | QP | L1 |

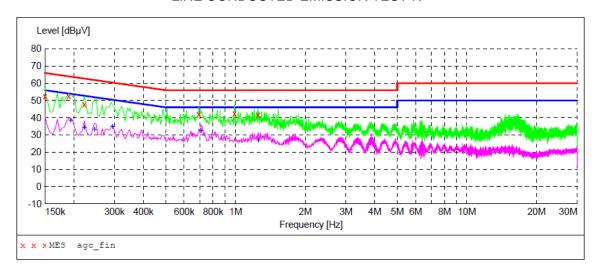
MEASUREMENT RESULT: "agc fin2"

| 20: | 23/7/31 11: Frequency MHz | | Transd dB | Limit dBµV | Margin dB | Detector | Line |
|-----|---------------------------------|-------|--------------|---------------|--------------|----------|------|
| | 0.638000 | 42.30 | 6.2 | 46 | 3.7 | AV | L1 |
| | 0.746000 | 34.70 | 6.2 | 46 | 11.3 | AV | L1 |
| | 0.798000 | 35.10 | 6.2 | 46 | 10.9 | AV | L1 |
| | 0.850000 | 35.20 | 6.2 | 46 | 10.8 | AV | L1 |
| | 1.170000 | 33.00 | 6.2 | 46 | 13.0 | AV | L1 |
| | 1.222000 | 35.00 | 6.2 | 46 | 11.0 | AV | L1 |

RESULT: PASS



LINE CONDUCTED EMISSION TEST-N



MEASUREMENT RESULT: "agc fin"

| 2023/7/31 | 1 11:0 | 9 | | | | | |
|-----------|-------------|---------------|--------------|---------------|--------------|----------|------|
| Freque | ency MHz | Level dBµV | Transd dB | Limit dBµV | Margin dB | Detector | Line |
| 0.150 | 0000 | 52.40 | 6.1 | 66 | 13.6 | QP | N |
| 0.190 | 0000 | 52.50 | 6.1 | 64 | 11.5 | QP | N |
| 0.222 | 2000 | 47.60 | 6.1 | 63 | 15.1 | QP | N |
| 0.694 | 4000 | 41.90 | 6.2 | 56 | 14.1 | QP | N |
| 0.990 | 0000 | 42.30 | 6.2 | 56 | 13.7 | QP | N |
| 1.250 | 0000 | 41.70 | 6.2 | 56 | 14.3 | QP | N |

MEASUREMENT RESULT: "agc fin2"

| 2023/7/31 | 11:10 | | | | | |
|-----------|--------|-------|--------|--------------|--------|----------|
| Frequer | _ | | | _ | | tor Line |
| ľ | MHz d | BμV | dB dBp | ı V d | В | |
| 0 1040 | 200 20 | 20 6 | 1 - | 4 15 | 7 7.77 | 37 |
| 0.1940 | 38 | .20 6 | .1 5 | 4 15. | 7 AV | N |
| 0.2220 | 000 34 | .30 6 | .1 5 | 3 18. | 4 AV | N |
| 0.2460 | 000 33 | .20 6 | .1 5 | 2 18. | 7 AV | N |
| 0.2940 | 000 34 | .60 6 | .1 5 | 0 15. | 8 AV | N |
| 0.7100 | 000 32 | .50 6 | .2 4 | 6 13. | 5 AV | N |
| 1.2580 | 000 26 | .70 6 | .2 4 | 6 19. | 3 AV | N |

RESULT: PASS

Note:

Measurement Level(dBuV) = Receiver reading(dBuV)+Tansd(dB)
Transd(dB)=AMN Factor(dB)+Cable Loss(dB)+Attenuation(dB) for Attenuator
Margin= Limit-Level



10. EN 55032 RADIATED EMISSION TEST

10.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3 m

| Frequency range (MHz) | Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance |
|-----------------------|---|
| 30 - 230 | 40 |
| 230 - 1000 | 47 |

Limits for radiated disturbance above 1 GHz at a measurement distance of 3 m

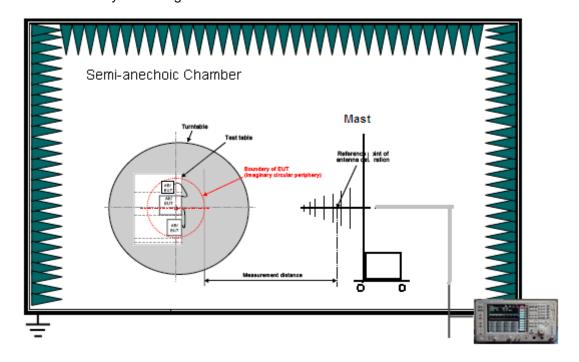
| Eroguenov rongo (MUT) | Limits (dBuV/m), Class B ITE | | | |
|-----------------------|------------------------------|---------|--|--|
| Frequency range (MHz) | Peak | Average | | |
| 1000-3000 | 70 | 50 | | |
| 3000-6000 | 74 | 54 | | |

Notes:

- 1. The lower limit shall apply at the transition frequency.
- 2. Additional provisions may be required for cases where interference occurs.

10.2. BLOCK DIAGRAM OF TEST SETUP

System Diagram of Connections between EUT and Simulators





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10.3. PROCEDURE OF RADIATED EMISSION TEST

- (1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55032 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 10cm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN 55032.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN 55032.
- (4) The EUT received charging voltage by adapter which got power through the outlet socket under the turntable. All support equipments received AC230V/50Hz power from socket under the turntable, if any.
- (5) The antenna was placed at 3 meter away from the EUT as stated in EN 55032. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- (6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- (7) The test mode(s) were scanned during the test:
- (8) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and Q.P./Peak reading is presented.



10.4. TEST RESULT OF RADIATED EMISSION TEST

Radiated Emission Test at 3m Distance - Horizontal



| No. | Mk. | Freq. | Reading Level | Correct Factor | Measure- ment | Limit | Over | |
|-----|-----|----------|------------------|-------------------|------------------|-------|--------|----------|
| | | MHz | dBuV | dB | dBuV/m | dB/m | dB | Detector |
| 1 | | 97.1148 | 13.18 | 15.75 | 28.93 | 40.00 | -11.07 | peak |
| 2 | 1 | 144.3348 | 12.70 | 14.55 | 27.25 | 40.00 | -12.75 | peak |
| 3 | 1 | 195.1365 | 18.59 | 13.94 | 32.53 | 40.00 | -7.47 | peak |
| 4 | * 2 | 265.6757 | 31.22 | 14.54 | 45.76 | 47.00 | -1.24 | QP |
| 5 | 4 | 147.9822 | 6.17 | 24.82 | 30.99 | 47.00 | -16.01 | peak |
| 6 | 9 | 903.3094 | 6.48 | 31.34 | 37.82 | 47.00 | -9.18 | peak |

RESULT: PASS



Radiated Emission Test at 3m Distance -Vertical



| No. | Mk | . Freq. | Reading Level | Correct Factor | Measure- ment | Limit | Over | |
|-----|----|----------|------------------|-------------------|------------------|-------|--------|----------|
| | | MHz | dBuV | dB | dBuV/m | dB/m | dB | Detector |
| 1 | | 47.1599 | 9.08 | 16.97 | 26.05 | 40.00 | -13.95 | peak |
| 2 | | 96.0986 | 18.40 | 14.73 | 33.13 | 40.00 | -6.87 | peak |
| 3 | | 114.9169 | 13.20 | 16.81 | 30.01 | 40.00 | -9.99 | peak |
| 4 | | 197.2001 | 12.39 | 17.98 | 30.37 | 40.00 | -9.63 | peak |
| 5 | * | 267.5455 | 23.23 | 18.09 | 41.32 | 47.00 | -5.68 | peak |
| 6 | | 938.8326 | 5.68 | 30.84 | 36.52 | 47.00 | -10.48 | peak |

RESULT: PASS

Note:

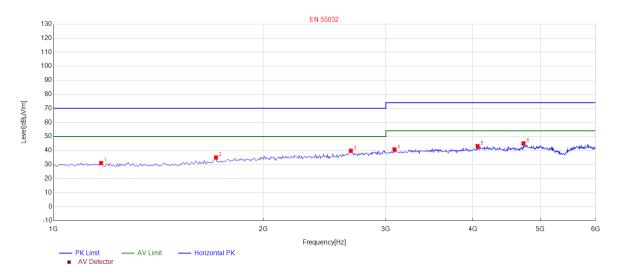
Level(dBuV/m)=Reading(dBuV)+Factor(dB/m)

Factor(dB/m)=Antenna Factor(dB/m)+Cable loss(dB)+Attenuation(dB)for Attenuator

Over= Measurement- Limit

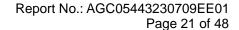


Radiated Emission Test at 3m Distance-Above 1G -Horizontal



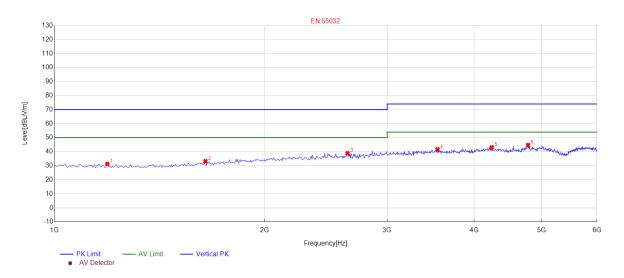
| NO. | Freq. [MHz] | Level [dBµV/m] | Factor [dB] | Limit [dBµV/m] | Margin [dB] | Height [cm] | Angle [°] | Polarity |
|-----|----------------|-------------------|----------------|-------------------|----------------|----------------|--------------|------------|
| 1 | 1170.1702 | 31.06 | -19.87 | 70.00 | 38.94 | 100 | 50 | Horizontal |
| 2 | 1710.7107 | 35.02 | -18.28 | 70.00 | 34.98 | 100 | 170 | Horizontal |
| 3 | 2671.6717 | 39.77 | -12.47 | 70.00 | 30.23 | 100 | 210 | Horizontal |
| 4 | 3087.0871 | 40.74 | -10.96 | 74.00 | 33.26 | 100 | 280 | Horizontal |
| 5 | 4063.0631 | 43.16 | -8.02 | 74.00 | 30.84 | 100 | 40 | Horizontal |
| 6 | 4728.7287 | 45.07 | -6.96 | 74.00 | 28.93 | 100 | 210 | Horizontal |

RESULT: PASS





Radiated Emission Test at 3m Distance Above 1G -Vertical



| NO. | Freq. [MHz] | Level [dBµV/m] | Factor [dB] | Limit [dBµV/m] | Margin [dB] | Height [cm] | Angle [°] | Polarity |
|-----|----------------|-------------------|----------------|-------------------|----------------|----------------|--------------|----------|
| 1 | 1190.1902 | 31.25 | -19.87 | 70.00 | 38.75 | 100 | 100 | Vertical |
| 2 | 1645.6456 | 33.21 | -18.79 | 70.00 | 36.79 | 100 | 150 | Vertical |
| 3 | 2631.6316 | 38.90 | -12.62 | 70.00 | 31.10 | 100 | 200 | Vertical |
| 4 | 3542.5425 | 41.71 | -9.56 | 74.00 | 32.29 | 100 | 310 | Vertical |
| 5 | 4238.2382 | 43.16 | -7.81 | 74.00 | 30.84 | 100 | 310 | Vertical |
| 6 | 4778.7788 | 44.76 | -6.84 | 74.00 | 29.24 | 100 | 170 | Vertical |

RESULT: PASS

Note:

Level(dBuV/m)=Reading(dBuV)+Factor(dB/m)

Factor(dB/m)=Antenna Factor(dB/m)+Cable loss(dB)+Attenuation(dB)for Attenuator

Margin= Limit-Level



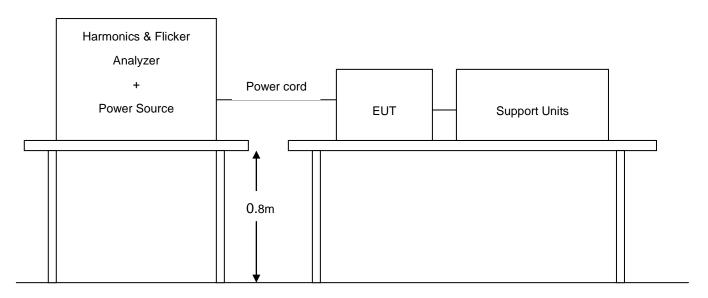
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11. EN IEC 61000-3-2 POWER HARMONICS TEST

POWER HARMONICS MEASUREMENT

| Port | AC mains |
|----------------|--|
| Basic Standard | EN IEC 61000-3-2 |
| Limits | ⊠CLASS A ;□CLASS B; □CLASS C; □CLASS D |
| Temperature | 23.1°C |
| Humidity | 58.5% RH |

11.1. BLOCK DIAGRAM OF TEST SETUP



11.2. RESULT

Note: Owning to the power of EUT is less than 75W, so test is not applicable.

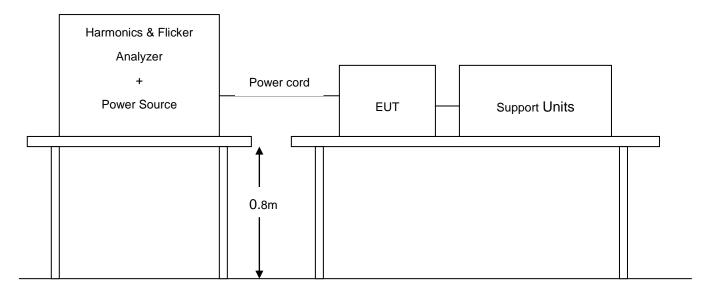


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12. EN 61000-3-3 VOLTAGE FLUCTUATION / FLICKER TEST VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

| Port | AC mains |
|----------------|--------------------|
| Basic Standard | EN 61000-3-3 |
| Limits | §5 of EN 61000-3-3 |
| Temperature | 23.1°C |
| Humidity | 58.5% RH |

12.1. BLOCK DIAGRAM OF TEST SETUP





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12.2. RESULT

Flicker Test Summary per EN/IEC61000-3-3 (Run time)

| | , . | <u> </u> | |
|-------------------------------|-------------------|----------|---------|
| Test Parameter | Measurement Value | Limit | Remarks |
| Time(mS) > dt: | 0.0 | 500.0 | Pass |
| Highest dc (%): | 0.00 | 3.30 | Pass |
| Highest dmax (%): | 0.00 | 4.00 | Pass |
| Highest Pst (10 min. period): | 0.273 | 1.0 | Pass |
| Highest Plt (2 hr. period): | 0.119 | 0.65 | Pass |



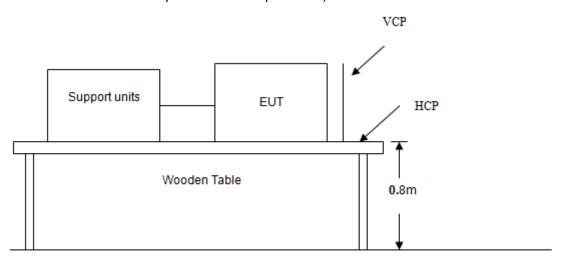
13. EN 61000-4-2 ESD IMMUNITY TEST

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

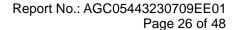
| Port | Enclosure |
|------------------|---|
| Basic Standard | EN 61000-4-2 |
| Test Level | ± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge) |
| Standard require | В |
| Temperature | 24.0°C |
| Humidity | 50.0% RH |

13.1. BLOCK DIAGRAM OF TEST SETUP

(The 470 k ohm resistors are installed per standard requirement)



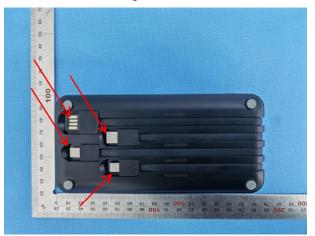
Ground Reference Plane₽





ESD LOCATION:

Red line: Contact discharge Blue line: Air discharge









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13.2. TEST PROCEDURE

The test procedure shall be in accordance with EN 61000-4-2. Electrostatic discharges shall be applied only to points and surfaces of the EUT which are expected to be touched during normal operation, including user access operations specified in the user manual, for example cleaning or adding consumables when the EUT is powered. The application of discharges to the contacts of open connectors is not required.

The number of test points is EUT dependent. Sub clause 8.3.1 and Clause A.5 of EN 61000-4-2 shall be taken into consideration when selecting test points, paying particular attention to keyboards, dialling pads, power switches, mice, drive slots, card slots, the areas around communication ports, etc.

When applying direct discharges to a portable or handheld battery-powered EUT with a display screen, it may not be possible to observe the screen for a given EUT orientation. If observation of the screen is necessary during this test, the EUT may be mounted vertically using non-metallic supports.

Note: As per the A2 to EN 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test. The electrostatic discharges were applied as follows:

| Voltage | Coupling | Test Performance | Result |
|---------|--------------------------------|------------------|--------|
| ±4kV | Contact Discharge | No function loss | А |
| ±4kV | Indirect Discharge HCP (Front) | No function loss | А |
| ±4kV | Indirect Discharge HCP (Left) | No function loss | А |
| ±4kV | Indirect Discharge HCP (Back) | No function loss | А |
| ±4kV | Indirect Discharge HCP (Right) | No function loss | А |
| ±4kV | Indirect Discharge VCP (Front) | No function loss | А |
| ±4kV | Indirect Discharge VCP (Left) | No function loss | А |
| ±4kV | Indirect Discharge VCP (Back) | No function loss | А |
| ±4kV | Indirect Discharge VCP (Right) | No function loss | А |
| ±8kV | Air Discharge | No function loss | А |

13.3. PERFORMANCE & RESULT

| | MANCE & RESULT |
|-------------|--|
| Criteria A: | The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. |
| Criteria B: | The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. |
| Criteria C: | Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |

| ⊠PASS | □ <i>FAIL</i> |
|-------|---------------|
| △FA33 | LIFAIL |

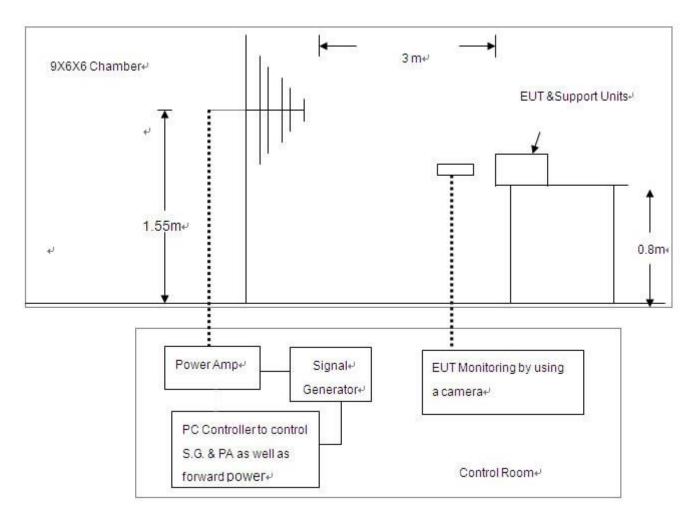


14. EN 61000-4-3 RS IMMUNITY TEST

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

| Port | Enclosure | |
|------------------|------------------------------------|--|
| Basic Standard | EN 61000-4-3 | |
| Test Level: | 3V/m with 80% AM. 1kHz Modulation. | |
| Standard require | A | |
| Temperature | 22.7°C | |
| Humidity | 59.4% RH | |

14.1. BLOCK DIAGRAM OF TEST SETUP





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14.2. TEST PROCEDURE

The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per EN 61000-4-3.

EUT worked with resistance load, and make sure EUT worked normally.

Setting the testing parameters of RS test software per EN 61000-4-3.

Performing the test at each side of with specified level (3V/m) at 1% steps and test frequency from 80MHz to 1000MHz

Recording the test result in following table.

EN 61000-4-3 Final test conditions:

Test level: 3V/m

Steps: 1 % of fundamental

Dwell Time: 1 sec

| Range (MHz) | Field | Modulation | Polarity | Position | Test Performance | Result |
|-------------------------|-------|------------|----------|----------|------------------|--------|
| 80-1000 | 3V/m | AM | H/V | Front | No function loss | А |
| 80-1000 | 3V/m | AM | H/V | Left | No function loss | А |
| 80-1000 | 3V/m | AM | H/V | Back | No function loss | А |
| 80-1000 | 3V/m | AM | H/V | Right | No function loss | А |
| 1800,2600, 3500,5000 | 3V/m | AM | H/V | Front | No function loss | А |
| 1800,2600, 3500,5000 | 3V/m | AM | H/V | Left | No function loss | А |
| 1800,2600, 3500,5000 | 3V/m | AM | H/V | Back | No function loss | А |
| 1800,2600, 3500,5000 | 3V/m | AM | H/V | Right | No function loss | А |

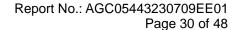
Frequency (±1 %) for Spot test.

14.3. PERFORMANCE & RESULT

| Criteria A: | The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. |
|-------------|--|
| Criteria B: | The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. |
| Criteria C: | Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |

| ∠ PASS | □FAIL | |
|--|--|------------------------------|
| Any report naving not been signed by authorized approver, or naving been aftered | u without authorization, or having not been stamped by the | Dedicated Testing/Inspection |

Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.



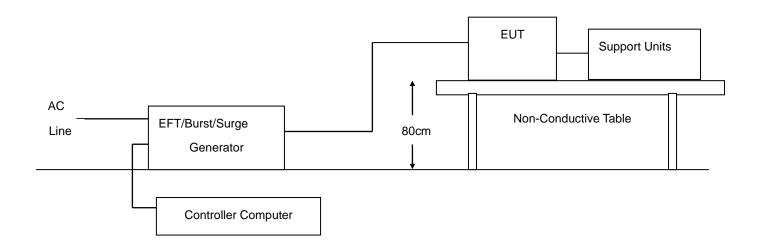


15. EN 61000-4-4 EFT IMMUNITY TEST

ELECTRICAL FAST TRANSIENTS/BURST IMMUNITY TEST

| Port | On Power Supply Lines | |
|------------------|-------------------------------|--|
| Basic Standard | N 61000-4-4 | |
| Test Level | /- 1kV for Power Supply Lines | |
| Standard require | В | |
| Temperature | 24°C | |
| Humidity | 59% RH | |

15.1. BLOCK DIAGRAM OF TEST SETUP





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15.2. TEST PROCEDURE

The EUT and support units were located on a wooden table 0.8m away from ground reference plane.

A 1.0 meter long power cord was attached to EUT during the test.

The length of communication cable between communication port and clamp was keeping within 1 meter.

EUT worked with resistance load, and make sure EUT worked normally.

Related peripherals work during the test.

Recording the test result as shown in following table.

Test conditions:

Impulse Frequency: 5kHz

Tr/Th: 5/50ns

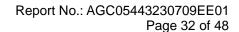
Burst Duration: 15ms Burst Period: 300ms

| Inject Line | Voltage kV | Inject Method | Test Performance | Result |
|-------------|------------|---------------|------------------|--------|
| L+N | +/- 1 | Direct | No function loss | Α |

15.3. PERFORMANCE & RESULT

| Criteria A: | The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. |
|-------------|--|
| Criteria B: | The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. |
| Criteria C: | Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |

|--|



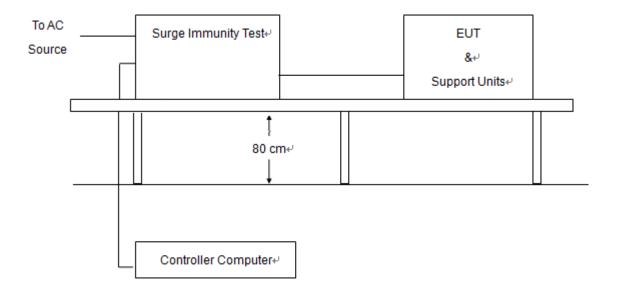


16. EN 61000-4-5 SURGE IMMUNITY TEST

SURGE IMMUNITY TEST

| Port | On Power Supply Lines | |
|------------------|------------------------|--|
| Basic Standard | EN 61000-4-5 | |
| Requirements | -/- 1kV (Line to Line) | |
| Standard require | В | |
| Temperature | 24°C | |
| Humidity | 59% RH | |

16.1. BLOCK DIAGRAM OF TEST SETUP





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16.2. TEST PROCEDURE

The EUT and support units were located on a wooden table 0.8 m away from ground floor.

EUT worked with resistance load, and make sure EUT worked normally.

Recording the test result as shown in following table.

Test conditions:

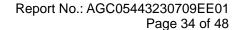
| Voltage Waveform | 1.2/50 <i>u</i> s | |
|-------------------------|-------------------|--|
| Current Waveform | /20 <i>u</i> s | |
| Polarity | Positive/Negative | |
| Phase angle | 90°,270° | |
| Number of Test | 5 | |

| Coupling Line | Voltage (kV) | Polarity | Coupling Method | Test Performance | Result |
|---------------|--------------|----------|-----------------|------------------|--------|
| L1-N | 1 | Positive | Capacitive | No function loss | А |
| L1-N | 1 | Negative | Capacitive | No function loss | А |

16.3. PERFORMANCE & RESULT

| Criteria A: | The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. |
|-------------|--|
| Criteria B: | The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. |
| Criteria C: | Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |

| ⊠PASS □FAIL |
|-------------|
|-------------|

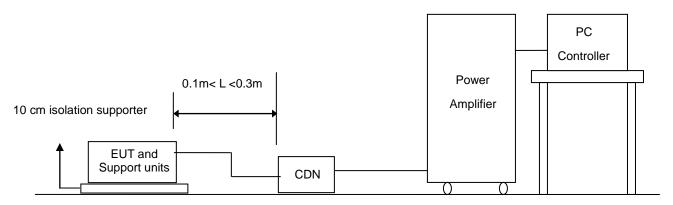




17. EN 61000-4-6 CS IMMUNITY TEST

| Port | On Power Supply Lines |
|------------------|--|
| Basic Standard | EN 61000-4-6 |
| Requirements | 3V(0.15MHz-10MHz) 3V-1V(10MHz-30MHz) 1V(30MHz-80MHz) with 80% AM. 1 kHz Modulation |
| Standard require | A |
| Temperature | 24°C |
| Humidity | 50% RH |

17.1. BLOCK DIAGRAM OF TEST SETUP



Ground Reference Plane



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17.2. TEST PROCEDURE

The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.

EUT worked with resistance load, and make sure EUT worked normally.

Related peripherals work during the test.

Setting the testing parameters of CS test software per EN 61000-4-6.

Recording the test result in following table.

Test conditions:

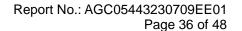
| Frequency Range | 0.15MHz-80MHz |
|--------------------|-------------------|
| Frequency Step | 1% of fundamental |
| Dwell Time | 3 sec |

| Range (MHz) | Strength | Modulation | Result |
|-------------|----------|------------|--------|
| 0.15-10 | 3V | AM | Α |
| 10-30 | 3V-1V | AM | Α |
| 30-80 | 1V | AM | А |

17.3. PERFORMANCE & RESULT

| Criteria A: | The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. |
|-------------|--|
| Criteria B: | The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. |
| Criteria C: | Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |

| □ FAIL | | ⊠ PASS | □FAIL |
|--------|--|---------------|-------|
|--------|--|---------------|-------|





18. EN 61000-4-11 DIPS IMMUNITY TEST

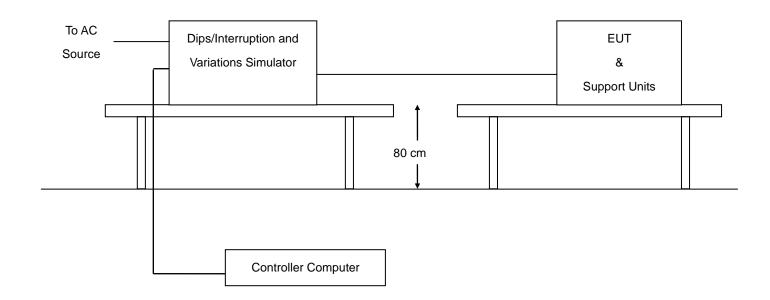
VOLTAGE DIPS. SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS IMMUNITY TEST

| VOLIAGE DII O | , SHOKI INTERROL HONS AND VOLIAGE VARIATIONS IMMONITY TEST |
|----------------|--|
| Port | On Power Supply Lines |
| Basic Standard | EN 61000-4-11 |
| Requirements | 0degrees |
| Test Interval | Min. 10 sec. |
| Temperature | 24°C |
| Humidity | 59% RH |

| | Test Level % U _T | Reduction (%) | Duration (periods) | Performance Criteria |
|--------------|--------------------------------|------------------|-------------------------|-------------------------|
| Voltage Dips | <5 | >95 | 0.5 | В |
| | 70 | 30 | 25 | С |

| Voltage | Test Level | Reduction | Duration | Performance |
|---------------|------------------|-----------|-------------|-------------|
| | % U _T | (%) | (periods) | Criteria |
| Interruptions | <5 | >95 | 250 | С |

18.1. BLOCK DIAGRAM OF TEST SETUP





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18.2. TEST PROCEDURE

The EUT and support units were located on a wooden table, 0.8 m away from ground floor.

EUT worked with resistance load, and make sure EUT worked normally.

Setting the parameter of tests and then perform the test software of test simulator.

Conditions changes to occur at 0 degree crossover point of the voltage waveform.

Recording the test result in test record form.

Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 s minimum (Between each test event)

Voltage Dips:

| Test Level % U _T | Reduction (%) | Duration (periods) | Observation | Performance Result |
|--------------------------------|------------------|--------------------|-------------|-----------------------|
| <5 | >95 | 0.5 | Normal | В |
| 70 | 30 | 25 | Normal | А |

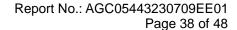
Voltage Interruptions:

| Test Level % U _T | Reduction (%) | Duration (periods) | Observation | Performance Result |
|--------------------------------|------------------|---------------------|--|-----------------------|
| <5 | >95 | 250 | EUT stopped working During testing, it was restored after a manual reboot. | В |

18.3. INTERPRETATION

| Criteria A: | The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. | |
|-------------|--|--|
| Criteria B: | The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. | |
| Criteria C: | Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. | |

| ⊠PASS □FAIL |
|-------------|
|-------------|



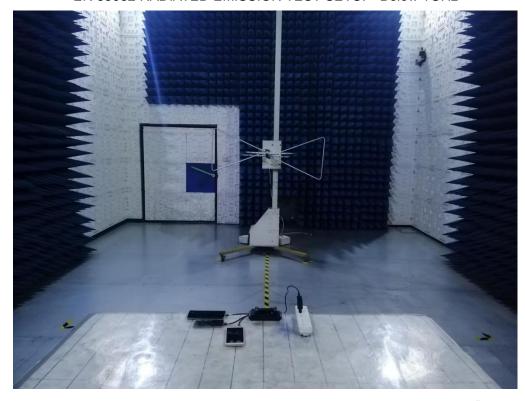


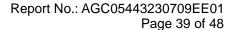
APPENDIX A: PHOTOGRAPHS OF TEST SETUP

EN 55032 CONDUCTED EMISSION TEST SETUP



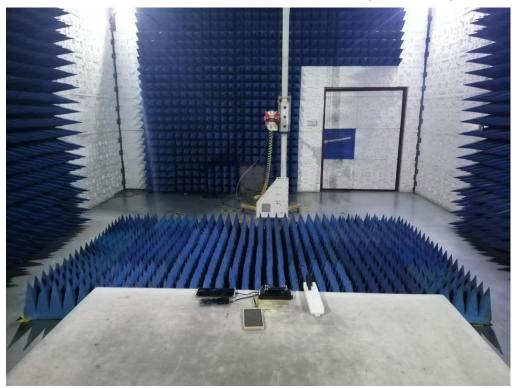
EN 55032 RADIATED EMISSION TEST SETUP- Below 1GHz





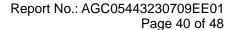






EN 61000-3-3 VOLTAGE FLUCTUATION / FLICKER TEST SETUP



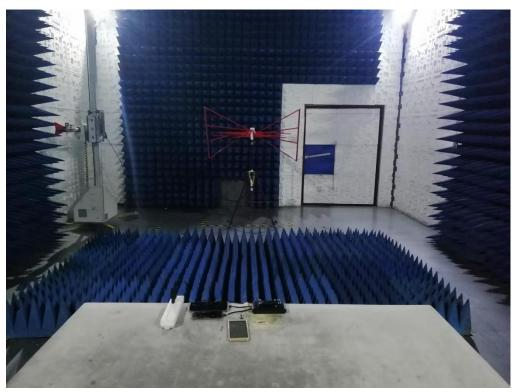




EN 61000-4-2 ESD IMMUNITY TEST SETUP

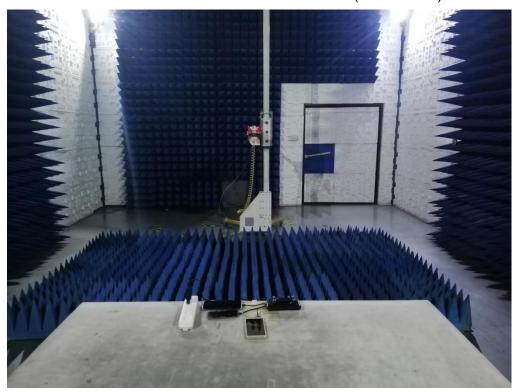


EN 61000-4-3 RS IMMUNITY TEST SETUP- Below 1GHz



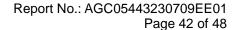


EN 61000-4-3 RS IMMUNITY TEST SETUP (Above 1GHz)



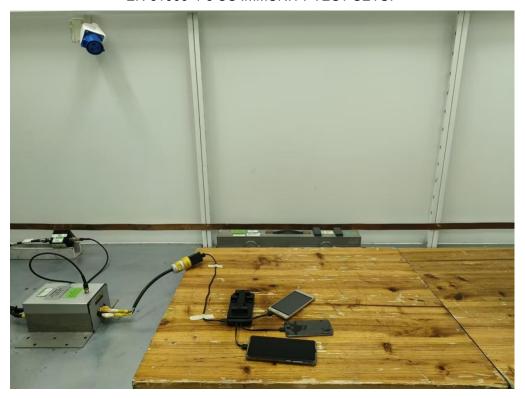
EN 61000-4-4/-5/-11 EFT/SURGE/DIPS IMMUNITY TEST SETUP

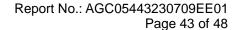






EN 61000-4-6 CS IMMUNITY TEST SETUP







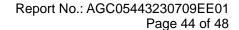
APPENDIX B: PHOTOGRAPHS OF EUT

ALL VIEW OF EUT



TOP VIEW OF EUT





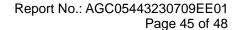


BOTTOM VIEW OF EUT



FRONT VIEW OF EUT







BACK VIEW OF EUT

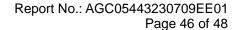


LEFT VIEW OF EUT



Any report having not been signed by authorized approver, or having been altered without authorization, or having not been stamped by the "Dedicated Testing/Inspection Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.

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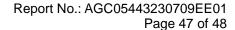


RIGHT VIEW OF EUT



OPEN VIEW OF EUT-1







OPEN VIEW OF EUT-2



BATTERY VIEW OF EUT

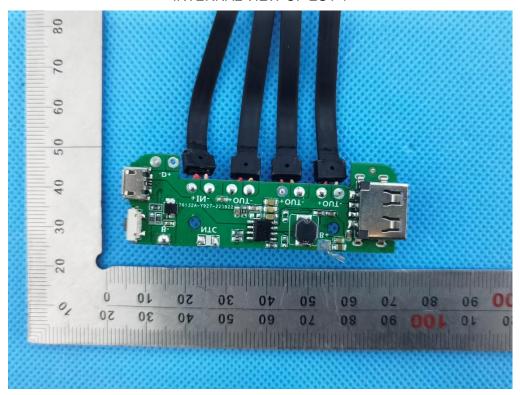


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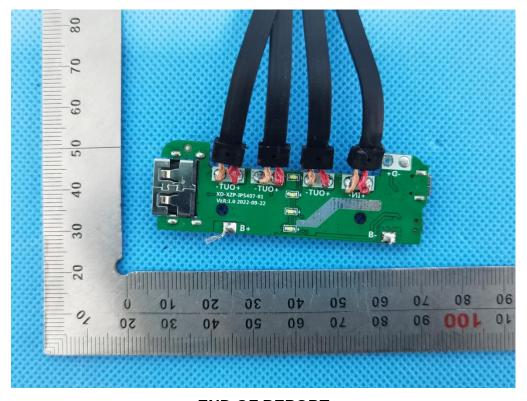
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INTERNAL VIEW OF EUT-1



INTERNAL VIEW OF EUT-2



----END OF REPORT----

Any report having not been signed by authorized approver, or having been altered without authorization, or having not been stamped by the "Dedicated Testing/Inspection Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.

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Conditions of Issuance of Test Reports

- 1. All samples and goods are accepted by the Attestation of Global Compliance (Shenzhen) Co., Ltd (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The company provides its services on the basis that such terms and conditions constitute express agreement between the company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by Company as a result of this application for testing services (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to its customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. In the event of the improper use of the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 5. Samples submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 6. The Company will not be liable for or accept responsibility for any loss or damage however arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 7.Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 8. The Company is not responsible for recalling the electronic version of the original report when any revision is made to them. The Client assumes the responsibility to providing the revised version to any interested party who uses them.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of the test report for a period of six years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after retention period. Under no circumstances shall we be liable for damage of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, incidental, indirect, consequential or punitive damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.